Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	264	(quality adj2 metric) near10 (determ\$5 or estimat\$5)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:21
L2	52	(quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:23
L3	3	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) same (interval)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 14:47
L4	1	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) same (decod\$3)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 14:48
L5	20	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and decod\$3	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 14:48
L6	6	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and decod\$3 and (criterion or criteria)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 14:49
L7	17	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and (criterion or criteria)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:21
L8	31	(((quality adj2 metric) near10 (determ\$5 or estimat\$5)) same threshold) and (criterion or criteria)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:21
L9	17	(((quality adj2 metric) near10 (determ\$5 or estimat\$5)) same threshold) and (criterion or criteria) and decod\$4	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:15
L10	41	sindhushayana-nag\$.in.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:15
L11	8	sindhushayana-nag\$.in. and (quality near2 metric\$1)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:17
L12	17	sindhushayana-nag\$.in. and (threshold)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:17
L13	30	sindhushayana-nag\$.in. and (decod\$4)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:17
L14	16	sindhushayana-nag\$.in. and (decod\$4) and threshold	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:18

L15	5	sindhushayana-nag\$.in. and (decod\$4) and threshold and (quality near2 metric\$1)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:19
L16	3	sindhushayana-nag\$.in. and (decod\$4) and criterion	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:19
L17	4	(((quality adj2 metric) near10 (determ\$5 or estimat\$5)) same threshold) same parameter\$1	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:21
L18	7	((quality adj2 metric) near10 (determ\$5 or estimat\$5)) and ((reduc\$5 or minimiz\$5 or decreas\$4) near4 power near3 decod\$4)	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:23
L19	0	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and 714/786.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:24
L20	0	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and 714/794.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:25
L21	1	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and 375/341.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:26
L22	0	((quality adj2 metric) near10 (determ\$5 or estimat\$5) near10 threshold) and 375/262.ccls.	USPAT; EPO; JPO; DERWENT	OR	OFF	2005/09/19 15:26

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L2	22	(reducing adj2 power adj2 consumption) near10 decoder	US-PGPUB	OR	OFF	2005/09/19 15:33
L3	3	((reducing adj2 power adj2 consumption) near10 decoder) and ("quality metric")	US-PGPUB	OR	OFF	2005/09/19 15:34
L5	31	("quality metric threshold")	US-PGPUB	OR	OFF	2005/09/19 15:36
L6	3	(delimiting near5 interval)	US-PGPUB	OR	OFF	2005/09/19 15:36

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IFFF STD	IEEE Standard		Volume 38, Issue 2, Feb. 2003 Page(s):319 - 328 Digital Object Identifier 10.1109/JSSC.2002.807414
			AbstractPlus References Full Text: PDF(1140 KB) IEEE JNL
			 DRG-cache: a data retention gated-ground cache for low power Agarwal, A.; Hai Li; Roy, K.; Design Automation Conference, 2002. Proceedings. 39th 10-14 June 2002 Page(s):473 - 478 Digital Object Identifier 10.1109/DAC.2002.1012671
			AbstractPlus Full Text: PDF(727 KB) IEEE CNF
			3. Leakage power optimization techniques for ultra deep sub-micron multi-li- Nam Sung Kim; Blaauw, D.; Mudge, T.; Computer Aided Design, 2003. ICCAD-2003. International Conference on 9-13 Nov. 2003 Page(s):627 - 632
			AbstractPlus Full Text: PDF(527 KB) IEEE CNF
			4. A low power turbo decoder architecture Elassal, M.; Bayoumi, M.; Signal Processing Systems, 2003. SIPS 2003. IEEE Workshop on 27-29 Aug. 2003 Page(s):105 - 110
			AbstractPlus Full Text: PDF(433 KB) IEEE CNF
			 Low-power approach for decoding convolutional codes with adaptive Vita approximations Henning, R.; Chakrabarti, C.; Low Power Electronics and Design, 2002. ISLPED '02. Proceedings of the 200

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IEE CNF	IEE Conference Proceeding						
IEEE STD	IEEE Standard	Digital Object Identifier 10.1109/ISCAS.2001.922210					
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		2. Reduced complexity blind rate detection for second and third gener systems Held, I.; Chen, A.; Global Telecommunications Conference, 1999. GLOBECOM '99 Volume 1A, 1999 Page(s):110 - 116 vol.1a Digital Object Identifier 10.1109/GLOCOM.1999.831618					
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